

**LIST OF ART CITED BY APPLICANT  
(PTO-1449)**

ATTY. DOCKET NO.  
**YHK-0135**

APPLN. SERIAL NO.  
**10/830,068**

APPLICANT(S)

**Young Joon AHN**

FILING DATE

**April 23, 2004**

GROUP

**2879**

**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
	<b>6,803,723</b>	<b>10-12-2004</b>	<b>Yamashita et al.</b>			

**U.S. PATENT APPLICATION PUBLICATIONS**

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
	<b>2001/038365</b>	<b>11-08-2001</b>	<b>Igeta et al.</b>			

**U.S. PATENT APPLICATIONS**

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	<b>0 788 131</b>	<b>08-06-1997</b>	<b>Europe</b>				
	<b>WO 01/29858</b>	<b>04-26-2001</b>	<b>PCT</b>				

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)**

European Search Report dated February 3, 2009.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.  
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